## Supporting Information

## Role of anions in Au complex for doping and degradation of graphene

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**Figure SI1.** a) The photographic image of pristine graphene on a glass substrate. b) The optical microscopic image of transferred pristine graphene on  $SiO_2$  wafer. c) The thickness profile and AFM image of pristine graphene on  $SiO_2$  wafer. The thickness of the few-layer graphene was 0.838 nm, indicating that 2 or 3 layers of graphene were synthesized.



**Figure SI2.** The Raman spectroscopy of transferred pristine graphene sheets as a function of growth temperature. The gas ratio of  $CH_4$  of  $H_2$  was fixed at 6:1. The G peak around 1550 cm<sup>-1</sup> and 2D peak around 2700 cm<sup>-1</sup> was due to the in-plane bond-stretching motion of the sp<sup>2</sup>-bonded carbon atoms and the monolayer graphene, respectively. The D peak around 1360 cm<sup>-1</sup> is absent in perfect graphite and indicates the presence of disorders and defects. The 950°C growth graphene had the highest  $I_G/I_D$  value and the acceptable value of  $I_{2D}/I_D$  for few-layer graphene sheets indicating that this was the best condition for few-layer graphene growth.



**Figure SI3.** The wide scan of the Au complex doped graphene sheets. Each Au complex doped graphene sheet had anions peak for Cl 2p, Br 3d, S 2p. The Au 4f peak indicated the presence of gold ions on the graphene sheets.



**Figure SI4.** The Au 4f peak separtion was investigated. In the case of the Au complex doped graphene, the AuCl<sub>3</sub> had the largest ion peak, which was related to the degree of the decrease in the sheet resistance. But annealed AuCl<sub>3</sub> doped graphene sheet contained no gold ion peaks, indicating that they were completely degraded by thermal annealing.



**Figure SI5.** The UPS speectra shows the secondary electron threshold energy differences. The AuBr<sub>3</sub> doped graphene sheets had the lowest secondary electron threshold energy value, indicating that they have the highest work function value. But the annealed graphene sheets had a larger secondary electron threshold energy value than that of each doped graphene sheets. The AuCl<sub>3</sub> doped graphene had the largest variance among the Au complex doped graphene sheets.